

<b>Notice of References Cited</b>	Application/Control No. 10/658,140	Applicant(s)/Patent Under Reexamination FRANK ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,904,034	06-2005	Kularatna et al.	370/338
	B	US-6,904,029	06-2005	Fors et al.	370/331
	C	US-6,870,822	03-2005	Balogh, Peter	370/332
	D	US-6,847,620	01-2005	Meier, Robert C.	370/328
	E	US-6,839,331	01-2005	Rudnick, William Michael	370/312
	F	US-6,801,781	10-2004	Provost et al.	455/466
	G	US-2004/0068668	04-2004	Lor et al.	713/201
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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